

ICS 31.18
CCS L 30

SJ

**INDUSTRY STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

SJ/T 11993-2025

**Testing method for the pad cratering of printed circuit board
assembly**

(English Translation)

Issued on: May 9, 2025

Implemented on: August 1, 2025

Issued by: Ministry of Industry and Information Technology

Table of Contents

What this standard covers	1
Document data	2

What this standard covers

This standard specifies the test procedures, result expression, and test report requirements for printed circuit board component pad cracking. This document applies to the evaluation test of the cracking resistance of rigid printed circuit boards and component pads.

Document data

International classification (ICS): 31.18.

Chinese classification (CCS): L30.

Estimated length of the Chinese original: 13,142 words.